

Lecture 15 - Switching losses and snubbers

1 Review



Transistor: Switch (on-off) or current source



Ideal switches

- Instantaneously turn on and off
- On-state: Zero voltage drop or zero resistor
- Off-state: zero current flow or infinite resistor
- No parasites \Rightarrow zero loss

Practical switches Finite time for turn on and turn off

- On-state: a voltage drop of a resistor
- Off-state: leakage current

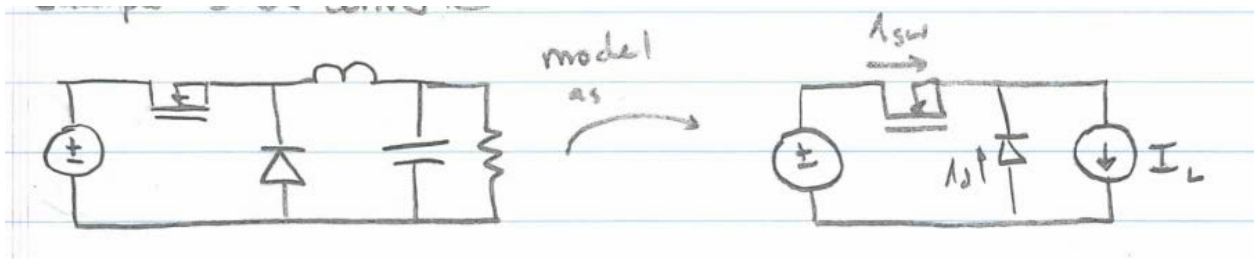
Parasitics: include a parallel capacitor, may include an anti-parallel diode \Rightarrow non-zero loss including conduction loss, switching loss (snubbers), gating loss, other losses

On-state: a voltage drop

	fully-controlled	half-controlled	uncontrolled
recall DC/DC lecture 2	BJT	IGBT	Diode
can:			
	block +v carry +i		block -v carry +i
on-state: a resistor	MosFET	GaN HEMT	
can:			
	block +v carry +i or -i		

2 Semiconductor losses (back of the envelope)

Example buck converter:



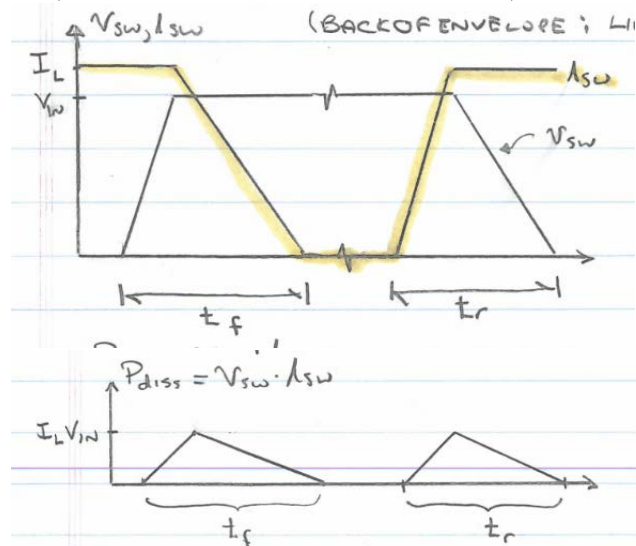
Device conduction losses:

MOSFETS look resistor $P_{FET,cond} \approx i_{sw,rms}^2 R_{ds,on} = (I_L^2 D) R_{ds,on}$

diodes look const drop $P_{d,cond} \approx \langle i_d \rangle V_{d,on} = (I_L D') V_{d,on}$

Device switching losses: occur as switches turn on and off

(Back of envelope: linear v,i transitions)



Turn off of MOSFET

Current falls after device voltage rises, because diode can't turn on (carry current) until $v_d \rightarrow 0$

Turn on of MOSFET

Current in mosfet must rise to full value (diode current goes to 0) before diode turns off + block voltage

t_f, t_r governed by devices and drivers

$$P_{sw, fet} \approx \left[\frac{1}{2} t_f I_L V_{in} + \frac{1}{2} t_r I_L V_{in} \right] f_{sw}$$

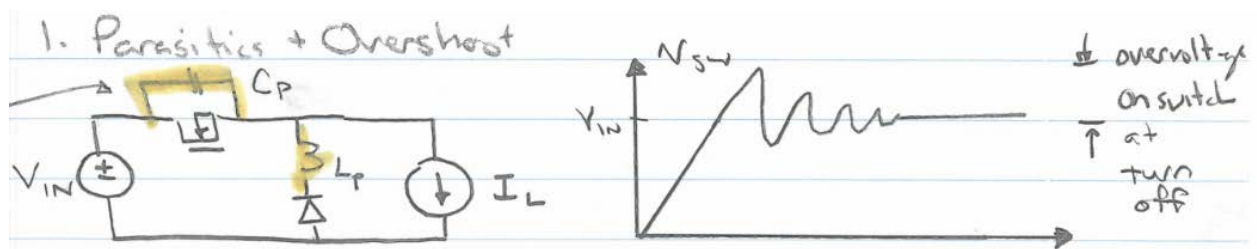
(Based on approximate linear transitions. Other losses and diode losses exist)

Note: major loss component $\approx f_{sw}$. We want $f_{sw} \uparrow$ to make L, C \downarrow but losses ultimately limit us.

We would like $t_r, t_f \downarrow$ to reduce switching loss, but other factor come into play:

1. Parasitics and overshoot

Lose capacitor energy $W = \frac{1}{2} C_p V_{in}^2$ on switch turn on



2. EMI

High $\frac{di}{dt}, \frac{dv}{dt}$ lead to EMI, may affect control circuits.

$\frac{di}{dt} \rightarrow$ magnetic coupling $v = L\mu \frac{di}{dt}$
 $\frac{dv}{dt} \rightarrow$ capacitive coupling $i = C \frac{dv}{dt}$

3. Rate limits

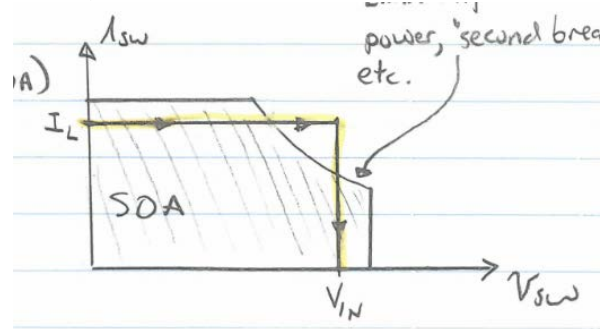
Some devices (BJT, GTO, MCT, MOSFETS are immune to these effects) have limits on allowed $\frac{dv}{dt}, \frac{di}{dt}$

high $\frac{di}{dt} \rightarrow$ destroy device on turn on

high $\frac{dv}{dt} \rightarrow$ can trigger device back on

4. Safe operations area (SOA)

Limit maybe instantaneous power, "second breakdown", etc.



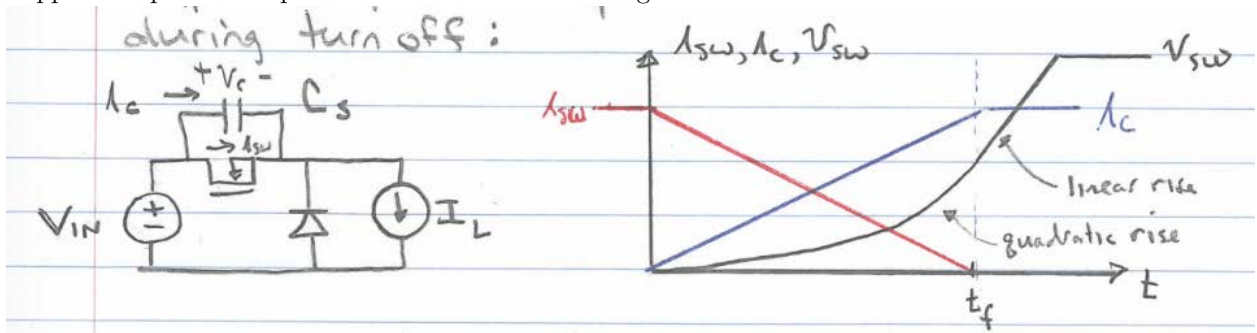
Some devices cannot sustain high simultaneous v,i.

3 Snubbers

1. Control switching losses

2. Reduce internal device dissipation

Suppose we placed a capacitor across the device during turn off:



I_L diverted through C_s while switch turns off:

$$i_{sw} = I_L \left(1 - \frac{t}{t_f}\right), 0 < t < t_f$$

$$i_c = I_L \frac{t}{t_f}, 0 < t < t_f$$

$$v_c = \frac{1}{C} \int_0^t i_c dt = \frac{I_L t^2}{2t_f C}, 0 < t < t_f$$

$$P_{diss,sw} = i_{sw} \cdot v_c = I_L \left(1 - \frac{t}{t_f}\right) \cdot \frac{I_L t^2}{2t_f C}, 0 < t < t_f$$

$$E_{diss} = \int_0^{t_f} i_{sw} \cdot v_c dt = \frac{I_L^2}{2t_f C} \int_0^{t_f} (t^2 - \frac{t^3}{t_f}) dt$$

$$E_{diss} = \frac{I_L^2}{2t_f C} (\frac{1}{3}t_f^3 - \frac{1}{4}t_f^3) = \frac{I_L^2 t_f^2}{24C}$$

We reduce device turn-off loss with the capacitor!

We also store energy in the capacitor $E_{stored} = \frac{1}{2} C V_{in}^2$

This is $\geq \frac{1}{2} C \frac{I_L^2 t_f^4}{4t_f^2 C^2} = \frac{I_L^2 t_f^2}{8C}$

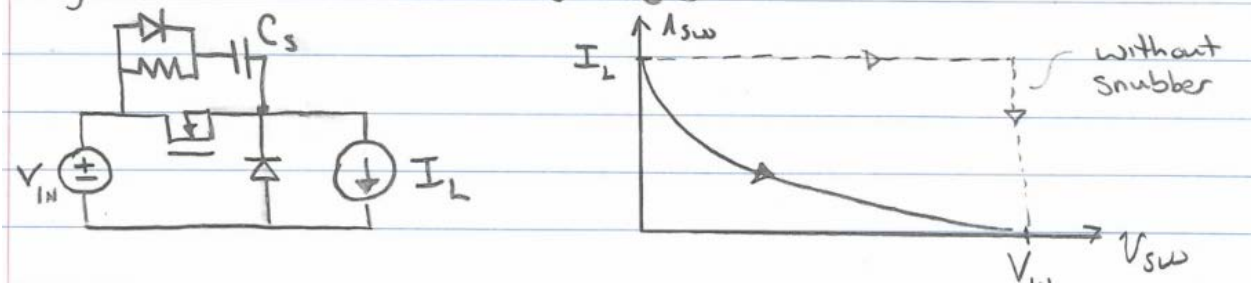
So: we reduce device loss @ turn off as $C \uparrow$ loss \downarrow

But: @ switch turn on, E_{stored} on cap gets dumped into switch!

- Could destroy switch!
- dumped energy increases as $C \uparrow$

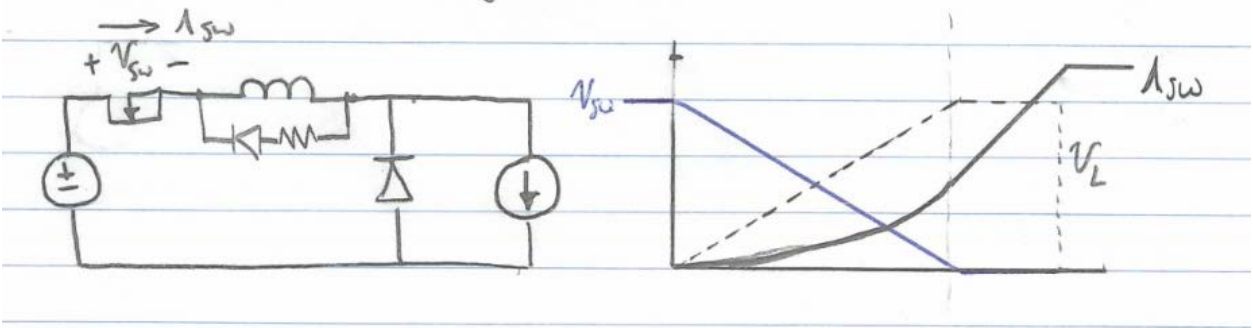
To build effective snubbers, we remove or recover the stored energy in some other fasion!

e.g. RCD turn-off snubber



- During turn off, C_s is effectively in parallel w/ the switch
- when switch is on, capacitor stored energy is slowly dissipated in R (we need some on-time to complete the discharge)
- Snubber only operates during switching transitions
 - \Rightarrow switching locus improved (SOA, lower $\frac{dv}{dt}$)
 - \Rightarrow device loss reduced (but total device and resistor loss is typically higher!)

We can do similar things at device turn on!



Reduces switch turn on losses

- Total switch and resistor losses maybe higher with snubber
- does not reduce loss associated with parasitic capacitance across the switch
- controls switching locus (SOA, $\frac{di}{dt} \downarrow$)
- results in slightly increased switch voltage
 - \rightarrow Could also describe gate drive techniques to get differential on/off transitions

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